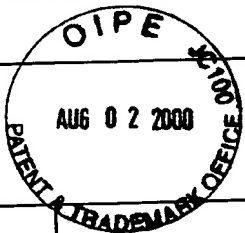



Sheet <u>1</u> of <u>1</u> SECOND LIST OF REFERENCES CITED BY APPLICANT (REVISED FORM PTO-1449) DATED: July 31, 2000										Atty. Docket No. 3905		Serial No.: 09/519,408		
										Applicant: Takao NAKAMURA et al.				
										U.S. Filing Date: March 3, 2000				Art Unit: 2811
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*EXAMINER INITIAL		DOCUMENT NO.						DATE	NAME	Cl.	Sub- Cl.	Fil. Date		
										-	-	-		
FOREIGN PATENT DOCUMENTS														
		DOCUMENT NO.						DATE	COUNTRY	Cl.	Sub- Cl.	Trans.		
												Yes	No	
WSL	AB	09	0	5	9	7	6	2	03/1997	Japan	-	-	x (Abstract)	
WSL	AC	2000	-	4	4	2	3	6	02/2000	Japan	-	-	x (Partial Translation)	
OTHER DOCUMENTS														
EXAMINER 										DATE CONSIDERED 5/21/01				
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.														

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Sheet 1 of 1Atty. Docket No.
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DATED: March 3, 2000

Applicant: Takao NAKAMURA et al.

U.S. Filing Date:
March 3, 2000

Art Unit:

JCS42 U.S. PTO
09/519408

U. S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	Cl.	Sub- Cl.	File Date
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.							DATE	COUNTRY	Cl.	Sub- Cl.	Trans.	
													Yes	No
WSE	AA	6-	3	1	8	4	0	6	11/1994	Japan	-	-	X (abst)	

OTHER DOCUMENTS

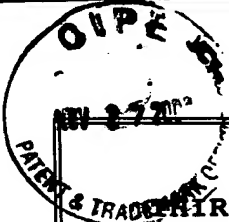
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Sheet 1 of 1

Atty. Docket
No. 3905

Serial No.:
09/519,408

**LIST OF REFERENCES CITED BY
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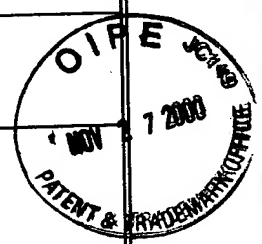
(REVISED FORM PTO-1449)

DATED: July 31, 2000

Applicant: Takao NAKAMURA et al.

U.S. Filing Date:
March 3, 2000

Art Unit:
2811



U. S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	Cl.	Sub- Cl.	File Date
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	Cl.	Sub- Cl.	Trans.	
							Yes	No
US	AD	05 1 3 9 7 3 5	06/1993	Japan	-	-	x (Abstract)	x

OTHER DOCUMENTS

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